

General Description

The AAT8512 is a low threshold MOSFET designed for the battery, cell phone, and PDA markets. Using AnalogicTech™'s ultra high density MOSFET process and space saving small outline J-lead package, performance superior to that normally found in a TSOP-6 footprint has been squeezed into the footprint of a SC70 package.

Features

- $V_{DS(MAX)} = -28V$ $I_{D(MAX)}^{1} = -3.3A @ 25^{\circ}C$
- Low $R_{DS(ON)}$:

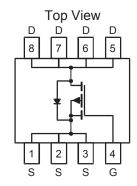
 90 mΩ @ V_{GS} = -4.5V

 150 mΩ @ V_{GS} = -2.5V

SC70JW-8 Package

Applications

- **Battery Packs**
- Cellular & Cordless Telephones
- Battery-powered portable equipment



Absolute Maximum Ratings (T_A=25°C unless otherwise noted)

Symbol	Description		Value	Units	
V _{DS}	Drain-Source Voltage		-28	V	
V _{GS}	Gate-Source Voltage		±12		
I _D	Continuous Drain Current @ T _J =150°C ¹	T _A = 25°C	±3.3	Α	
		T _A = 70°C	±2.6		
I _{DM}	Pulsed Drain Current ²		±20		
I _S	Continuous Source Current (Source-Drain Diode) 1		-0.9		
P _D	Maximum Power Dissipation ¹	T _A = 25°C	1.6	W	
		T _A = 70°C	1.0	V V	
T _J , T _{STG}	Operating Junction and Storage Temperature Range		-55 to 150	°C	

Thermal Characteristics

Symbol	Description	Тур	Max	Units	
$R_{\theta JA}$	Junction-to-Ambient steady state 1	102	125	°C/W	
$R_{\theta JA2}$	Junction-to-Ambient t<5 seconds 1	63	78	°C/W	
$R_{\theta JF}$	Junction-to-Foot 1	35	42	°C/W	



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Description	Conditions	Min	Тур	Max	Units
DC Charac	DC Characteristics					'
B _{VDSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250μA	-28			V
	Drain-Source ON-Resistance ²	V _{GS} =-4.5V, I _D =-3.3A		72	90	mΩ
R _{DS(ON)}		V _{GS} =-2.5V, I _D =-2.5A		115	150	11122
I _{D(ON)}	On-State Drain Current ²	V_{GS} =-4.5V, V_{DS} =-5V (Pulsed)	-20			Α
V _{GS(th)}	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_{D}=-250\mu A$	-0.6			V
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±12V, V _{DS} =0V			±100	nA
	Drain Source Leakage Current	V_{GS} =0V, V_{DS} =-28V			1	
I _{DSS}		V_{GS} =0V, V_{DS} =-23V, T_J =70°C			5	μA
9 _{fs}	Forward Transconductance ²	V_{DS} =-5V, I_{D} =-3.3A		7		S
Dynamic C	characteristics ³					•
Q_G	Total Gate Charge	V_{DS} =-15V, R_{D} =4.5 Ω , V_{GS} =-4.5V		6.9		
Q_{GS}	Gate-Source Charge	V_{DS} =-15V, R_{D} =4.5 Ω , V_{GS} =-4.5V		0.9		nC
Q_{GD}	Gate-Drain Charge	V_{DS} =-15V, R_{D} =4.5 Ω , V_{GS} =-4.5V		2.5		
t _{D(ON)}	Turn-ON Delay	V_{DS} =-15V, R_D =4.5 Ω , V_{GS} =-4.5V, R_G =6 Ω		7		
t_R	Turn-ON Rise Time	V_{DS} =-15V, R_D =4.5 Ω , V_{GS} =-4.5V, R_G =6 Ω		30		ns
t _{D(OFF)}	Turn-OFF Delay	V_{DS} =-15V, R_D =4.5 Ω , V_{GS} =-4.5V, R_G =6 Ω		60		115
t _F	Turn-OFF Fall Time	V_{DS} =-15V, R_{D} =4.5 Ω , V_{GS} =-4.5V, R_{G} =6 Ω		35		
Source-Dra	Source-Drain Diode Characteristics					
V _{SD}	Source-Drain Forward Voltage ²	V _{GS} =0, I _S =-3.3A			-1.4	V
I _S	Continuous Diode Current ¹				-0.9	Α

Note 1: Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5 second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications. $R_{\theta JF} + R_{\theta FA} = R_{\theta JA}$ where the foot thermal reference is defined as the normal solder mounting surface of the device's leads. $R_{\theta JF}$ is guaranteed by design, however $R_{\theta CA}$ is determined by the PCB design. Actual maximum continuous current is limited by the application's design.

Note 2: Pulse test: Pulse Width = 300 μ s

Note 3: Guaranteed by design. Not subject to production testing.

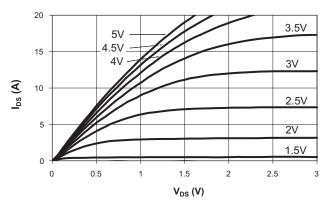
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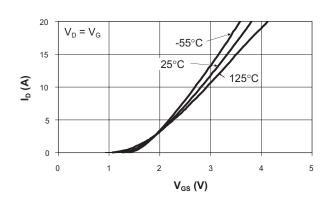
Typical Characteristics

(T_{.1} = 25°C unless otherwise noted)

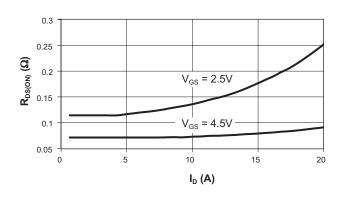
Output Characteristics



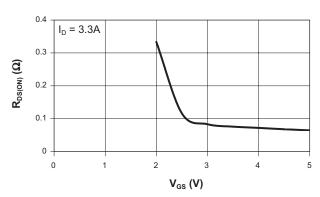
Transfer Characteristics



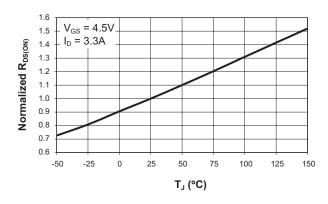
On-Resistance vs. Drain Current



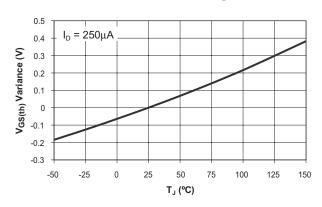
On-Resistance vs. Gate to Source Voltage



On-Resistance vs. Junction Temperature



Threshold Voltage

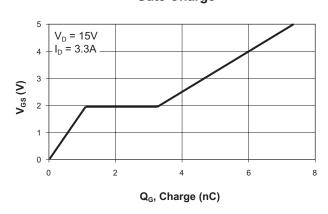




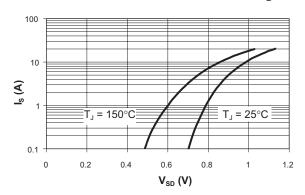
Typical Characteristics

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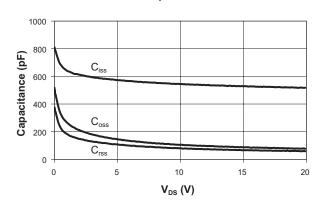
Gate Charge



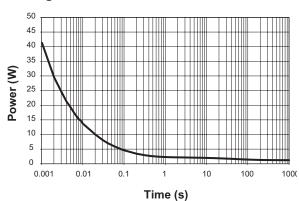
Source-Drain Diode Forward Voltage



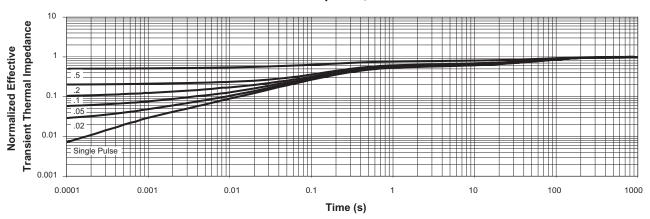
Capacitance



Single Pulse Power, Junction to Ambient



Transient Thermal Response, Junction to Ambient





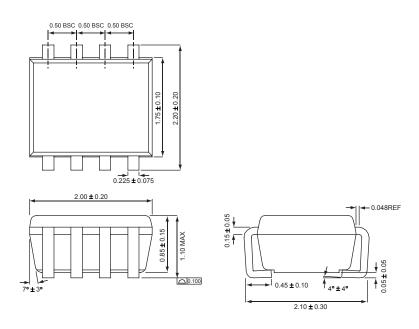
Ordering Information

Package	Marking ¹	Part Number (Tape and Reel)
SC70JW-8	KSXYY	AAT8512IJS-T1

Note 1: XYY = assembly and date code.

Package Information

SC70JW-8



All dimensions in millimeters.



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